

<b>Notice of References Cited</b>	Application/Control No. 10/762,722	Applicant(s)/Patent Under Reexamination YEH ET AL.	
	Examiner Jennifer A. Leung	Art Unit 1764	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,590,265	05-1986	Bogan et al.	536/63
*	B	US-5,458,856	10-1995	Marie et al.	422/186
*	C	US-3,168,817	02-1965	BECKMAN JOHN H; et. al.	62/45.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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